Electronic Patent Application Fee Transmittal							
Application Number:	10773524						
Filing Date:	06-Feb-2004						
Title of Invention:	Defect inspection apparatus and defect inspection method						
First Named Inventor/Applicant Name:	Takashi Yoneyama						
Filer:	Leonard Holtz/Nalini Sahadeo						
Attorney Docket Number:	04083/LH						
Filed as Large Entity							
Utility Filing Fees							
Description		Fee Code	Quantity	Amount	Sub-Total in USD(\$)		
Basic Filing:							
Pages:							
Claims:							
Miscellaneous-Filing:							
Petition:							
Patent-Appeals-and-Interference:							
Post-Allowance-and-Post-Issuance:							
Extension-of-Time:							
Extension - 2 months with \$0 paid		1252	1	460	460		

Description	Fee Code	Quantity	Amount	Sub-Total in USD(\$)
Miscellaneous:				
	Total in USD (\$)			460